

<b>PTO/SB/08A (08-03)</b> <b>U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE</b> <b>Substitute for Form 1449A/PTO</b>  <b>INFORMATION DISCLOSURE</b> <b>STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>	<b>APPLICATION NO.:</b> 10/780,264	<b>FILING DATE:</b> February 16, 2004
	<b>INVENTOR(S):</b> Wolczko et al.	<b>ART UNIT:</b> 2192
	<b>EXAMINER NAME:</b> Chou, Andrew Y.	<b>ATTY. DOCKET NO.:</b> 188073/US

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		Country Code <sup>3</sup> – Number <sup>4</sup> – Kind Code <sup>5</sup> (if known)	MM-DD-YYYY			

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OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS			
EXAMINER INITIALS	Cite No. <sup>1</sup>	Include name of Author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), volume-issue number(s), publisher, page(s) and date.	T <sup>6</sup>
	15.	Author Unknown, "IA-32 Intel Architecture Software Developer's Manual, Volume 3: System Programming Guide", Intel Corporation, 1997.	
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